Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,838	BEENAU ET AL.	
Examiner	Art Unit	
Daniel I. Walsh	2876	

	SEARCHED		
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search attached	4/11/2006	DW
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